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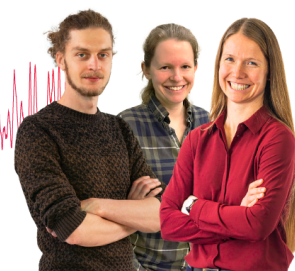
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# Development of a polarimetry method toward *in situ* substrate birefringence characterization of ground-based gravitational wave detectors

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Satoshi Tanioka,<sup>a)</sup> Terri Pearce, and Keiko Kokeyama

## AFFILIATIONS

School of Physics and Astronomy, Cardiff University, Cardiff CF24 3AA, United Kingdom

<sup>a)</sup> Author to whom correspondence should be addressed: [TaniokaS@cardiff.ac.uk](mailto:TaniokaS@cardiff.ac.uk)

## ABSTRACT

Improving the sensitivity of gravitational wave detectors is necessary to enrich scientific outcome of gravitational wave astronomy. Birefringence in test mass mirrors of gravitational wave detectors can become an important factor for both current and next-generation gravitational wave detectors to achieve improved performance. *In situ* birefringence characterization can become an essential diagnostic tool for detector performance and needs to be established. We report a possible *in situ* birefringence characterization method and its experimental results with a tabletop setup. The scheme proposed and demonstrated in this paper can be used as a diagnostic tool in large-scale gravitational wave detectors. We also discuss possible technological developments toward implementation in future gravitational wave detectors.

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## I. INTRODUCTION

Ground-based laser interferometric gravitational wave detectors (GWDs) have opened a new window on the universe by enabling direct detection of gravitational waves (GWs).<sup>1,2</sup> Those GWDs are based on dual-recycled Fabry-Pérot Michelson interferometers to achieve sufficient sensitivity to enable direct detection of GWs.<sup>3–5</sup> Next-generation GWDs, such as Cosmic Explorer and the Einstein Telescope, will enhance the scientific impact of gravitational wave astronomy by increasing the sensitivity by one order of magnitude compared with current GWDs.<sup>6,7</sup>

Development of high-quality test masses will play a crucial role both in improving the performance of current GWDs and in the realization of next-generation GWDs.<sup>8</sup> One of the important properties to be assessed in such test masses is the birefringence distribution. Crystalline sapphire test masses are employed in KAGRA, which performed an observing run with a configuration of power-recycled Fabry-Pérot Michelson interferometer.<sup>9</sup> Recent studies in KAGRA have revealed that inhomogeneous birefringence in sapphire input test masses (ITMs) degrade the performance of the detector.<sup>10,11</sup> The typical differential phase retardation induced by

birefringence is of the order of 100 nm per single trip, which corresponds to about 0.6 rad.<sup>12</sup> Such birefringence in an ITM is known to affect the detector performance as it can degrade the power-recycling gain (PRG), resulting in a reduced circulating power.<sup>13</sup> In addition to the PRG reduction, the ITM birefringence can affect the contrast of the interferometer and reduce the achievable squeezing level.<sup>4,14,15</sup>

While a tabletop setup can characterize the test mass birefringence, the actual birefringence distribution can be altered by a stress induced by a suspension or by cooling down to cryogenic temperature. In particular, next-generation GWDs will employ a few hundred kilogram test masses, which may be susceptible to substantial stress, resulting in stress-induced birefringence.<sup>6,7</sup> In addition, their test masses are thicker than the current test masses, which can therefore enhance the phase retardation as shown in Eq. (3). Even if the test mass birefringence is pre-characterized by using a tabletop setup, the installation process to the GWD can introduce unexpected birefringence due to strain applied to the test masses—an effect that has not been rigorously evaluated. In addition, test mass birefringence may vary during long term observation, a possibility that has also not been systematically tested. Therefore, *in situ*

birefringence characterization will play an important role in understanding the properties of test masses and evaluating the performance of the GWDs.

In tabletop experiments, the test mass birefringence can be characterized by rotating either the input beam polarization or the sample mirror itself.<sup>12,16–18</sup> However, neither can be rotated in GWDs. Therefore, in order to realize the *in situ* birefringence characterization, it is necessary to develop a method that does not require rotation of the input beam polarization or the test mass.

In this paper, we propose and demonstrate a polarimetry approach to enable *in situ* test mass birefringence characterization in a gravitational wave detector. We have developed a tabletop setup, which shows reasonable repeatability and measurement results. We also discuss further developments toward implementing the proposed birefringence characterization scheme to GWDs.

## II. BIREFRINGENCE CALCULATION

### A. Definition

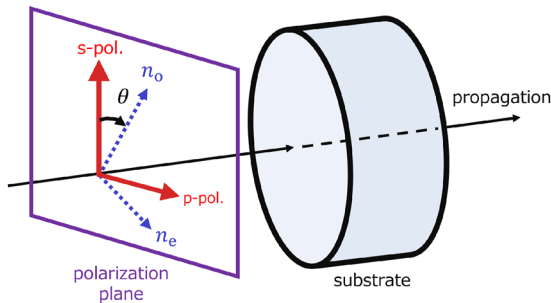
We define parameters and geometry to characterize the birefringence distribution as shown in Fig. 1. In the same manner as the previous work, we set s- and p-polarization axes in the vertical and horizontal directions with respect to the laboratory frame.<sup>12</sup> The polarization state of the light field can be expressed as

$$|E\rangle = \begin{pmatrix} E_s \\ E_p \end{pmatrix}, \quad (1)$$

where  $E_s$  and  $E_p$  are the electric field of the s- and p-polarized fields, respectively.

When a substrate material exhibits birefringence, that property can be described by refractive index difference,  $\Delta n$ , between two distinctive orthogonal axes,  $n_o$  and  $n_e$ . These two orthogonal refractive index axes are, respectively, called ordinary and extraordinary axes. Here, we assume that these axes are rotated by an angle of  $\theta$  with respect to the polarization axes as shown in Fig. 1.

The polarization state of the light field can be modified when it passes through the birefringent substrate. Similar to the previous work, we define the following common and differential phase changes as<sup>12</sup>



**FIG. 1.** Schematic of the definition. The mirror substrate has two orthogonal refractive index axes,  $n_o$  and  $n_e$ , which are rotated by  $\theta$  from s- and p-polarization axes, respectively.

$$\alpha_+ := \frac{\pi d}{\lambda} (n_o + n_e), \quad (2)$$

$$\alpha_- := \frac{\pi d}{\lambda} (n_o - n_e), \quad (3)$$

where  $d$  is the thickness of the sample and  $\lambda$  is the laser wavelength. By using these definitions, the Jones matrix of the birefringent sample,  $\hat{M}$ , can be expressed as

$$\hat{M} = e^{i\alpha_+} \begin{pmatrix} \cos \alpha_- + i \sin \alpha_- \cos 2\theta & i \sin \alpha_- \sin 2\theta \\ i \sin \alpha_- \sin 2\theta & \cos \alpha_- - i \sin \alpha_- \cos 2\theta \end{pmatrix}. \quad (4)$$

In this convention, the range of the orientation and differential phase retardation are  $-45^\circ \leq \theta \leq 45^\circ$  and  $-\pi/2 \leq \alpha_- \leq \pi/2$ , respectively. Note that the sign of  $i \sin \alpha_- \sin 2\theta$  is flipped compared with the previous work due to the difference in the definition of  $\theta$ .<sup>12</sup>

In our setup, the s-polarized beam is used as an input beam in the same manner as in KAGRA.<sup>19</sup> The electric field of the input beam can be described as

$$|E_{\text{in}}\rangle = \begin{pmatrix} E_{\text{in}} \\ 0 \end{pmatrix}, \quad (5)$$

where  $E_{\text{in}} := E_0 e^{i\Omega t}$ ,  $E_0 \in \mathbb{C}$  is the amplitude of the field, and  $\Omega$  is the laser angular frequency. When the s-polarized beam passes through the birefringent sample, the transmitted light field becomes

$$\hat{M}|E_{\text{in}}\rangle = E_{\text{in}} e^{i\alpha_+} \begin{pmatrix} \cos \alpha_- + i \sin \alpha_- \cos 2\theta \\ i \sin \alpha_- \sin 2\theta \end{pmatrix}. \quad (6)$$

Therefore, the input beam field is scattered into orthogonal polarization depending on the parameters of the birefringent sample  $\alpha_-$  and  $\theta$ .

### B. Characterization method

In this subsection, we describe the birefringence characterization method. Instead of rotating the input beam polarization or the birefringent sample, we rotate the polarization of the transmitted beam through the sample.

In our setup, as shown in Fig. 2, a half-wave plate (HWP) is inserted right after the sample. The Jones matrix of a HWP can be expressed as

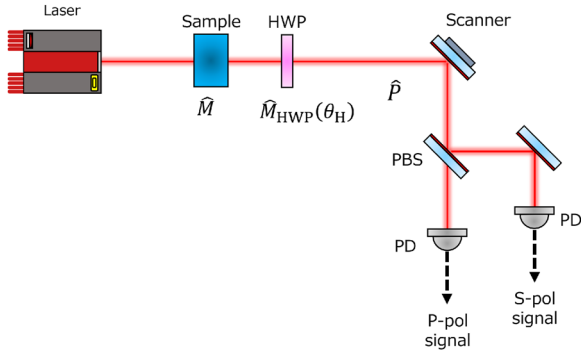
$$\hat{M}_{\text{HWP}}(\theta_H) = \begin{pmatrix} \cos 2\theta_H & \sin 2\theta_H \\ \sin 2\theta_H & -\cos 2\theta_H \end{pmatrix}, \quad (7)$$

where  $\theta_H$  is the orientation of the HWP. Then, the field after the HWP becomes

$$|E_{\text{out}}(\theta_H)\rangle = \hat{M}_{\text{HWP}}(\theta_H) \hat{M}|E_{\text{in}}\rangle. \quad (8)$$

First, we consider the case when the HWP orientation is aligned to the horizontal and vertical directions, i.e.,  $\theta_H = 0$ . The Jones matrix of the HWP becomes

$$\hat{M}_{\text{HWP}}(0) = \begin{pmatrix} 1 & 0 \\ 0 & -1 \end{pmatrix}. \quad (9)$$



**FIG. 2.** Simplified schematic of the experimental setup. The input beam is conditioned to be an s-polarized beam using polarizers (not shown in this figure). After transmitting the HWP, the beam is split into s- and p-polarized beams using a PBS, and each beam power is detected by using a PD.

Here, we assumed that the input beam is a purely s-polarized beam. From Eqs. (6) and (8), the electric field after transmitting both the birefringent sample and the HWP with  $\theta_H = 0$  can be written as

$$|E_{\text{out}}(0)\rangle = E_{\text{in}} e^{i\alpha_+} \begin{pmatrix} \cos \alpha_- + i \sin \alpha_- \cos 2\theta \\ -i \sin \alpha_- \sin 2\theta \end{pmatrix}. \quad (10)$$

The beam power for each polarization can be calculated as

$$|E_{\text{in}}|^2 \begin{pmatrix} \cos^2 \alpha_- + \sin^2 \alpha_- \cos^2 2\theta \\ \sin^2 \alpha_- \sin^2 2\theta \end{pmatrix}. \quad (11)$$

We detect the beam power of each polarization by using a polarized beam splitter (PBS) and photodiodes (PDs). We define the normalized output beam power with the HWP angle of  $\theta_H$  as

$$V(\theta_H) := \begin{pmatrix} V_s(\theta_H) \\ V_p(\theta_H) \end{pmatrix}. \quad (12)$$

When  $\theta_H = 0$ , the normalized output beam power becomes

$$V(0) = \begin{pmatrix} V_s(0) \\ V_p(0) \end{pmatrix} = \begin{pmatrix} \cos^2 \alpha_- + \sin^2 \alpha_- \cos^2 2\theta \\ \sin^2 \alpha_- \sin^2 2\theta \end{pmatrix}. \quad (13)$$

Note that  $\sin^2 \alpha_- \sin^2 2\theta$  corresponds to the optical loss induced by the birefringence.

Then, we rotate the HWP by  $\pi/8$ . The Jones matrix of the HWP becomes

$$\hat{M}_{\text{HWP}}(\pi/8) = \frac{1}{\sqrt{2}} \begin{pmatrix} 1 & 1 \\ 1 & -1 \end{pmatrix}. \quad (14)$$

One can compute the fields at PDs in the same way and arrive at

$$\begin{pmatrix} V_s(\pi/8) \\ V_p(\pi/8) \end{pmatrix} = \frac{1}{2} \begin{pmatrix} \cos^2 \alpha_- + \sin^2 \alpha_- (\cos 2\theta + \sin 2\theta)^2 \\ \cos^2 \alpha_- + \sin^2 \alpha_- (\cos 2\theta - \sin 2\theta)^2 \end{pmatrix}. \quad (15)$$

From Eq. (15), this can be rewritten as

$$V_s(\pi/8) - V_p(\pi/8) = 2 \sin^2 \alpha_- \sin 2\theta \cos 2\theta. \quad (16)$$

By dividing  $V_p(0)$  by  $V_s(\pi/8) - V_p(\pi/8)$ , one can get

$$\frac{V_p(0)}{V_s(\pi/8) - V_p(\pi/8)} = \frac{1}{2} \tan 2\theta. \quad (17)$$

Therefore, the orientation of the birefringence can be obtained from

$$\theta = \frac{1}{2} \arctan \left( \frac{2V_p(0)}{V_s(\pi/8) - V_p(\pi/8)} \right). \quad (18)$$

From  $V_p(0)$  and Eq. (18), one can obtain the absolute value of  $\alpha_-$  as

$$|\alpha_-| = \arcsin \left( \frac{\sqrt{V_p(0)}}{|\sin 2\theta|} \right). \quad (19)$$

Similarly, one can extract the birefringence,  $\theta$  and  $|\alpha_-|$ , when the input beam is p-polarized.

### III. EXPERIMENTAL SETUP

#### A. Configuration

Figure 2 shows our experimental setup. A 1064 nm wavelength laser is employed here. The input beam is an s-polarized Gaussian beam with a polarization extinction ratio better than  $10^3$ . The HWP is mounted on a rotational mount, which has a vernier scale so that one can determine the HWP rotation angle precisely. The output beam from the HWP is split into s- and p-polarized beams using a PBS. Then, each beam is detected using a pinhole PD, which has an aperture of  $55 \mu\text{m}$ . The distance between the scanner and each PD is set at 470 mm. The beam diameter on the sample and that on each PD are 2.6 and 1.2 mm, respectively.

In front of the PBS, a scanner is placed, which is used as in the phase camera setup in Advanced Virgo.<sup>20,21</sup> This scanner allows us to scan the beam on each PD so that the beam power distribution affected by the birefringent sample can be obtained. Similar to the Advanced Virgo setup, the following Archimedean spiral pattern is employed in our setup:

$$x(t) = R_{\text{img}} \frac{t}{T_{\text{img}}} \cos(2\pi f_{\text{scan}} t), \quad (20)$$

$$y(t) = R_{\text{img}} \frac{t}{T_{\text{img}}} \sin(2\pi f_{\text{scan}} t). \quad (21)$$

Here,  $R_{\text{img}}$ ,  $T_{\text{img}}$ , and  $f_{\text{scan}}$  are the radius of the image, the acquisition time for one image, and the spiral rotation frequency, respectively. In our setup, each scanning time  $T_{\text{img}}$  is set to be 1 s. This scanning pattern enables a smooth trajectory and thus a smooth mirror movement. We scan over the beam diameter, i.e.,  $\sim 1.2$  mm in this setup, so that the birefringence distribution within the beam diameter can be characterized.

The output signal from each PD during scanning the beam is acquired using a digital system called CDS, which is used in Advanced LIGO.<sup>4</sup> Analog PD signals are converted to digital signals (counts) by 16 bit analog-to-digital converters (ADCs). The signals are recorded as counts for each measurement.

#### B. Propagator

In reality, some optics are placed between the HWP and the PDs as shown in Fig. 2. For instance, a mirror on the scanner can

have different transmissivities for s- and p-polarizations. Such optical components affect the beam power at the PDs. We define this effect as

$$V_{PD} = \hat{P}V(\theta_H), \quad (22)$$

where

$$\hat{P} := \begin{pmatrix} P_{11} & P_{12} \\ P_{21} & P_{22} \end{pmatrix} \quad (23)$$

denotes the propagation matrix from the HWP to the PDs. In order to make a birefringence map, we need to convert  $V_{PD}$  to  $V(\theta_H)$ . This can be done by multiplying the inverse of  $\hat{P}$  as

$$V(\theta_H) = \hat{P}^{-1}V_{PD}. \quad (24)$$

The propagator,  $\hat{P}$ , can be measured with pure s- and p-polarizations without a sample. When the output beam from the HWP has pure p-polarization,

$$\begin{aligned} V_{PD} &= \hat{P} \begin{pmatrix} 1 \\ 0 \end{pmatrix} \\ &= \begin{pmatrix} P_{11} \\ P_{21} \end{pmatrix}. \end{aligned} \quad (25)$$

Similarly, when the input beam has pure s-polarization, one can obtain

$$V_{PD} = \begin{pmatrix} P_{12} \\ P_{22} \end{pmatrix}. \quad (26)$$

From these two measurements, one can determine the propagation matrix  $\hat{P}$ . Prior to the measurement with a sample, we characterized the propagator with this method.

#### IV. RESULTS

To verify the validity and repeatability of the proposed method, a birefringence map of a quarter-wave plate (QWP) was measured as it has a fixed value of  $|\alpha_-| = \pi/4$ . A zero-order QWP (WPQ10M-1064) from THORLABS was used as a sample in our setup.<sup>22</sup> Five sets of measurements were taken for each of the three different orientations.

Table I summarizes the obtained results, and Fig. 3 shows the typical result of the birefringence distributions and their histograms. In Table I, we describe the values of  $\theta$  and  $\alpha_-$ , which give the peak values in their histograms. Both the orientation and the differential phase retardation can be measured within  $\sim \pm 0.3^\circ$  in  $\theta$  and  $\sim \pm 0.02$  rad in  $\alpha_-$ , respectively. Within the beam diameter where the beam is most sensitive to disturbance such as birefringence, the measured orientation and differential phase retardation show reasonable homogeneity.

The measured results indicate that the proposed characterization method has reasonable repeatability regardless of the axis orientation. The sapphire substrate used in KAGRA showed the one-way differential phase change of  $\alpha_- \approx 0.6$  rad.<sup>12</sup> Therefore, our setup has sufficient sensitivity and repeatability for *in situ* birefringence

**TABLE I.** Summary of the results. Each direction of the QWP was chosen at random. The differential phase retardation of the QWP is fixed at  $\alpha_- = \pi/4 = 0.785$ . Peak values are presented as measured values.

Estimated values		Measured values (peak)	
$\theta (^\circ)$	$\alpha_- (\text{rad})$	$\theta (^\circ)$	$\alpha_- (\text{rad})$
$\approx 19$	$\pi/4 = 0.785$	18.51	0.789
		19.31	0.784
		19.03	0.788
		18.81	0.791
		18.93	0.794
$\approx 34$	$\pi/4 = 0.785$	33.99	0.771
		33.99	0.770
		33.97	0.770
		33.91	0.770
		33.80	0.771
$\approx -12$	$\pi/4 = 0.785$	-12.05	0.791
		-12.21	0.790
		-12.38	0.784
		-11.97	0.791
		-12.36	0.776

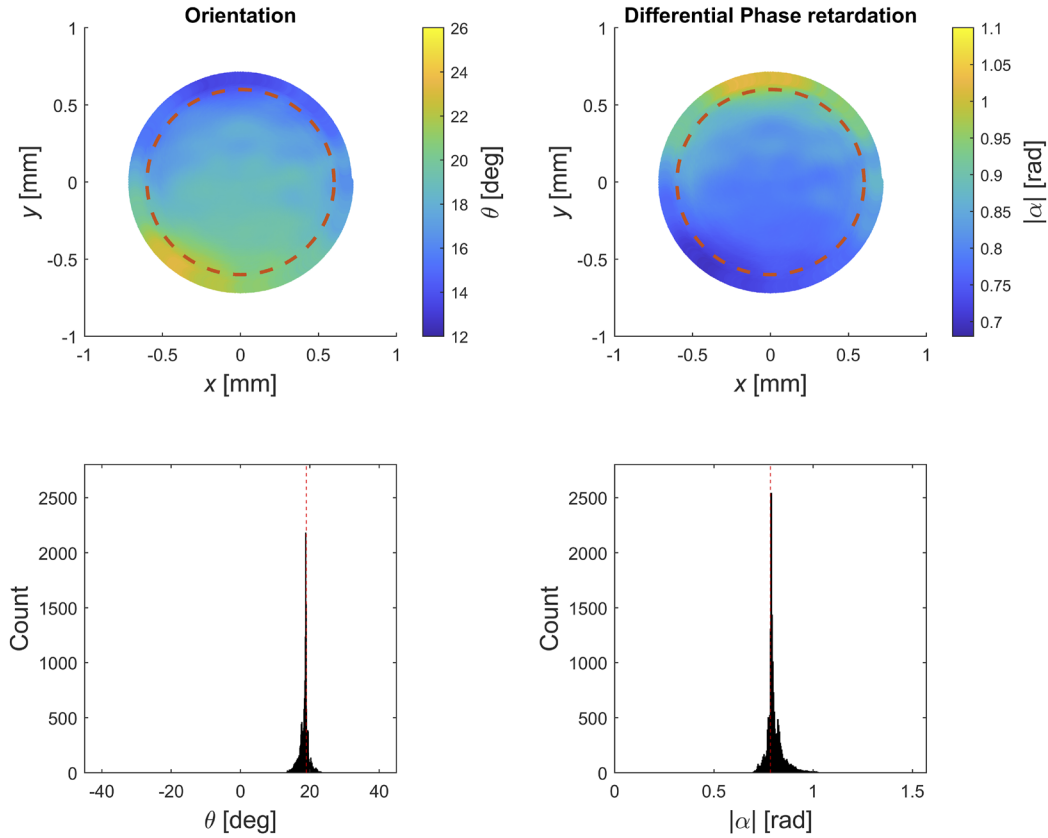
analysis in current KAGRA sapphire mirrors. For the case of next-generation GWDs, such as Cosmic Explorer, a 38 cm-thick fused silica substrate is planned to be employed with a 1064 nm wavelength main laser. Assuming that the birefringence of such fused silica is  $\Delta n = 10^{-7}$ , which is the upper limit of the required value mentioned in Ref. 7, the differential phase is  $\alpha_- \approx 0.22$  rad per round trip, which is in the same order of the measured sample in our setup ( $\alpha_- \approx 0.78$  rad). Therefore, the proposed scheme can be useful even for Cosmic Explorer. In Sec. IV A, we investigate error sources such that the proposed scheme can have enough signal-to-noise ratio to probe birefringence in future GWDs.

#### A. Discussions on the error

We discuss possible error sources that might limit the performance of the proposed scheme.

##### 1. Input beam polarization extinction ratio

The input beam extinction ratio needs to be kept as low as possible as it can couple to  $V_p(0)$ . As long as the p-polarized input beam power ratio is much smaller than  $\sin^2 \alpha_- \sin^2 2\theta$ , the impacts on the birefringence measurement can be ignored. For instance,  $V_p(0)$  is typically in order of  $10^{-1}$ ; therefore, as long as the input beam extinction ratio is kept better than  $10^3$ , i.e., 60 dB, it will not greatly affect the birefringence characterization. When the input beam extinction ratio becomes worse than 60 dB, that couples to the beam power introduced by birefringence,  $V_p(0) = \sin^2 \alpha_- \sin^2 2\theta$  in Eq. (13). In our setup, the extinction ratio was kept below this level so that the measurements were not disturbed. This level can be achieved in the GWDs. For instance, in Advanced LIGO, a Faraday isolator is employed as the input optics, whose polarization extinction ratio is better than  $10^5 = 100$  dB.<sup>23</sup>



**FIG. 3.** Typical birefringence maps (upper) and their histogram (bottom) with the QWP. The red dashed circles in the birefringence maps correspond to the beam diameter at the PDs (1.2 mm). The red dashed lines in the histograms are the estimated values  $19^\circ$  and  $\pi/4$ , respectively. The histograms indicate that the measured values are consistent with the estimated values.

## 2. HWP misalignment

When the HWP axis has a small misalignment,  $\delta\theta_H (\ll 1)$ , it introduces a systematic error in the birefringence map. This effect can be estimated as follows:  $V(0)$  in Eq. (13) can be replaced by  $V(\delta\theta_H)$ . Assuming that  $\delta\theta_H \ll 1$ , we can approximate the Jones matrix of the HWP as

$$\begin{aligned} \hat{M}_{\text{HWP}}(\delta\theta_H) &= \begin{pmatrix} 1 - 2\sin^2(\delta\theta_H) & \sin(2\delta\theta_H) \\ \sin(2\delta\theta_H) & -1 + 2\sin^2(\delta\theta_H) \end{pmatrix} \\ &\approx \begin{pmatrix} 1 & 2\delta\theta_H \\ 2\delta\theta_H & -1 \end{pmatrix}. \end{aligned} \quad (27)$$

Here, we ignore the second-order terms with respect to  $\delta\theta_H$ . From Eq. (10), the output field with a small HWP misalignment can be expressed as

$$\begin{aligned} |E_{\text{out}}(\delta\theta_H)\rangle &= E_{\text{in}} e^{i\alpha_+} \\ &\times \begin{pmatrix} \cos \alpha_- + i \sin \alpha_- \cos 2\theta + 2i\delta\theta_H \sin 2\theta \\ -i \sin \alpha_- \sin 2\theta + 2\delta\theta_H (\cos \alpha_- - i \sin \alpha_- \cos 2\theta) \end{pmatrix}. \end{aligned} \quad (28)$$

Then, the normalized beam power can be computed as

$$V(\delta\theta_H) \approx \left( \frac{\cos^2 \alpha_- + \sin^2 \alpha_- \cos^2 2\theta}{\sin^2 \alpha_- \sin^2 2\theta + 4\delta\theta_H \sin^2 \alpha_- \sin 2\theta \cos 2\theta} \right). \quad (29)$$

As long as  $4\delta\theta_H \sin^2 \alpha_- \sin 2\theta \cos 2\theta$  is much smaller than  $\sin^2 \alpha_- \sin^2 2\theta$ , the impact of the HWP misalignment can be negligible. This requirement can be rewritten as

$$\frac{4\delta\theta_H \sin^2 \alpha_- \sin 2\theta \cos 2\theta}{\sin^2 \alpha_- \sin^2 2\theta} = \frac{4\delta\theta_H}{\tan 2\theta} \ll 1. \quad (30)$$

Typically,  $\tan 2\theta$  is in the order of unity. Therefore, as long as  $\delta\theta_H$  should be kept below a few mrad, i.e.,  $\lesssim 0.2^\circ$ , the HWP misalignment will not significantly affect the results. This requirement can be achieved even with a motorized rotation mount, which has 0.1 mrad minimum incremental motion.<sup>24</sup>

## 3. Quantization noise

One of the noise sources, which can ultimately limit the sensitivity to birefringence, is quantization noise, often called the ADC noise. The digital system we use to acquire data causes the





$$|E_{\text{out}}(\theta_H)\rangle = \hat{M}_{\text{HWP}}(\theta_H) \hat{M}_{\text{prop}} \hat{M}|E_{\text{in}}\rangle. \quad (32)$$

The normalized beam power can be modified as

$$V'(0) = \begin{pmatrix} t_s^2 \cos^2 \alpha_- + \sin^2 \alpha_- \cos^2 2\theta \\ t_p^2 \sin^2 \alpha_- \sin^2 2\theta \end{pmatrix}, \quad (33)$$

$$V'(\pi/8) = \frac{1}{2} \begin{pmatrix} t_s^2 \cos^2 \alpha_- + \sin^2 \alpha_- (t_s \cos 2\theta + t_p \sin 2\theta)^2 \\ t_s^2 \cos^2 \alpha_- + \sin^2 \alpha_- (t_s \cos 2\theta - t_p \sin 2\theta)^2 \end{pmatrix}. \quad (34)$$

These lead to changes in results as follows:

$$\frac{V'_p(0)}{V'_s(\pi/8) - V'_p(\pi/8)} = \frac{t_p}{2t_s} \tan 2\theta. \quad (35)$$

Thus,

$$\theta = \frac{1}{2} \arctan \left( 2 \frac{t_s}{t_p} \frac{V'_p(0)}{V'_s(\pi/8) - V'_p(\pi/8)} \right). \quad (36)$$

As long as the optical properties are properly characterized, we can compensate the transmissivity imbalance in post-processing. The absolute value of differential phase retardation,  $|\alpha_-|$ , can also be derived in the same way,

$$|\alpha_-| = \arcsin \left( \frac{\sqrt{V'_p(0)}}{|t_p \sin 2\theta|} \right). \quad (37)$$

## 2. Relative phase delay

The BS introduces not only transmissivity imbalance but also a relative phase delay between s- and p-polarized beams.<sup>25</sup> The Jones matrix of such a relative phase delay can be expressed as

$$\hat{M}_{\text{delay}} = \begin{pmatrix} 1 & 0 \\ 0 & e^{i\phi} \end{pmatrix}, \quad (38)$$

where  $\phi$  denotes the relative phase delay. Then, Eq. (8) can be rewritten as

$$|\tilde{E}_{\text{out}}(\theta_H)\rangle = \hat{R}(\theta_H) \hat{M}_{\text{delay}} \hat{M} E_{\text{in}}. \quad (39)$$

Therefore, the results can be affected by this phase delay. When  $\theta_H = 0$ , the normalized beam powers do not change. However, when we rotate the HWP such that  $\theta_H = \pi/8$ , the above equation becomes

$$|\tilde{E}_{\text{out}}(\theta_H)\rangle = \hat{R}(\pi/8) \hat{M}_{\text{delay}} \hat{M} E_{\text{in}}. \quad (40)$$

The normalized beam power can be calculated as

$$\begin{pmatrix} \tilde{V}_s(\pi/8) \\ \tilde{V}_p(\pi/8) \end{pmatrix} = \frac{1}{2} \begin{pmatrix} 1 - 2 \cos \alpha_- \sin \alpha_- \sin 2\theta \sin \phi + 2 \sin^2 \alpha_- \sin 2\theta \cos 2\theta \cos \phi \\ 1 + 2 \cos \alpha_- \sin \alpha_- \sin 2\theta \sin \phi - 2 \sin^2 \alpha_- \sin 2\theta \cos 2\theta \cos \phi \end{pmatrix}. \quad (41)$$

When the beam experiences some relative phase delay between the sample and the HWP, the differential normalized beam power between s- and p-polarizations becomes

$$\tilde{V}_s(\pi/8) - \tilde{V}_p(\pi/8) = 2 \sin^2 \alpha_- \sin 2\theta \cos 2\theta \cos \phi - 2 \sin \alpha_- \cos \alpha_- \sin 2\theta \sin \phi. \quad (42)$$

Even if the phase delay of  $\phi$  is known, one cannot derive the birefringence,  $\alpha_-$  and  $\theta$ , as  $\tilde{V}_s - \tilde{V}_p$  is a nonlinear function.

Although the relative phase delay in the optics prevents us from birefringence characterization, this can be addressed by inserting a variable phase shifter, such as an electro-optic modulator (EOM), in front of the HWP.<sup>26</sup> The Jones matrix of a phase shifter can be expressed as

$$\hat{M}_{\text{PS}} = \begin{pmatrix} 1 & 0 \\ 0 & e^{i\varepsilon} \end{pmatrix}, \quad (43)$$

where  $\varepsilon$  is the relative phase between s- and p-polarizations. Here, we ignore the transmissivity of the phase shifter for each polarization as it can be compensated as shown above. The phase retardation,  $\varepsilon$ , can be easily controlled by changing the applied voltage to the retarder.

Once we know the phase delay,  $\phi$ , we can set  $\varepsilon = -\phi$  so that we can eliminate its impact. Then, the proposed birefringence characterization method can be applied. While the EOM can be used as the phase shifter, if there is significant non-uniform birefringence in the EOM, the relative phase delay may not be fully compensated. In addition, the phase shifter may need to be calibrated occasionally since the phase retardation,  $\varepsilon$ , may change over time.

We are planning to perform further study and verification of the compensation schemes for both transmissivity imbalance and relative phase delay. In particular, the impacts of the EOM as the phase shifter will be evaluated in the future.

## VI. CONCLUSION

A novel scheme for *in situ* birefringence characterization of a gravitational wave detector has been proposed and demonstrated with a tabletop experiment. We have shown the working principle of the birefringence mapping scheme that is compatible with a scanning pinhole phase camera used in the gravitational wave detector. Therefore, the proposed polarimetry birefringence mapping method is able to characterize the *in situ* birefringence distribution and birefringent optical loss in a gravitational interferometer.



In order to implement this system in a GWD, phase-delay and transmissivity imbalance introduced by the optics need to be assessed and compensated. We are currently planning to perform an experimental verification of the compensation scheme and demonstration for implementation in GWDs.

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## AUTHOR DECLARATIONS

### Conflict of Interest

The authors have no conflicts to disclose.

## Author Contributions

**Satoshi Tanioka:** Conceptualization (equal); Data curation (lead); Methodology (lead); Validation (lead); Visualization (lead); Writing – original draft (lead); Writing – review & editing (equal). **Terri Pearce:** Conceptualization (equal); Data curation (equal); Investigation (equal); Methodology (equal); Writing – review & editing (equal). **Keiko Kokeyama:** Conceptualization (equal); Investigation (equal); Methodology (equal); Supervision (lead); Writing – review & editing (equal).

## DATA AVAILABILITY

The data that support the findings of this study are available from the corresponding author upon reasonable request.

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